

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Toas and Knapp

Confirmation No. 5057

Serial No.: 10/772,063

Group Art Unit: 1771

Filed: February 4, 2004

Examiner: Matzek, Matthew D.

For: Insulation Product Having Antimicrobial/Antifungal Facing, Facing for Same, and Process for Making Same

I CERTIFY THAT THIS CORRESPONDENCE IS BEING DEPOSITED WITH THE U.S. POSTAL SERVICE AS FIRST CLASS MAIL IN AN ENVELOPE ADDRESSED TO THE COMMISSIONER FOR PATENTS, P.O. BOX 1450, ALEXANDRIA, VA 22313.

ON December 15, 2004  
BY Mary La Grange

M.S. Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

INFORMATION DISCLOSURE STATEMENT TRANSMITTAL LETTER

Enclosed herewith is an Information Disclosure Statement pursuant to 37 CFR. § 1.56 in connection with the above-identified application, which statement is being filed:

Together with the present application.

Before the first Office Action on the merits or three (3) months from the filing date of this application, whichever occurs last. [37 CFR § 1.97(b)]

After the first Office Action on the merits, but before a Final Office Action under §1.113 or Notice of Allowance under §1.311, whichever occurs first. [37 CFR §1.97(c)]. (Either the fee or certification is provided, as set forth below).

After a Final Office Action under §1.113 or Notice of Allowance under §1.311, but prior to or with payment of the Issue Fee. [37 CFR §1.97(d)]. The fee and certification are provided, as set forth below).

Consistent with Applicant's obligations pursuant to 37 CFR §§1.97 and 1.98, the following requirements have been met:

- [ ] No separate requirements are needed.
- [ ] No additional fee is required.

**Fee Under 37 CFR § 1.97(c) or 1.97(d)**

[ ] The fee of \$180.00 for submission of an IDS under § 1.97(c) as set forth in § 1.17(p) accompanies this statement.

[X] The Commissioner is hereby authorized to charge the fee of \$180.00 for submission of an IDS under § 1.97(c) as set forth in § 1.17(p) to Deposit Account No. 04-1679.

**Certification Under 37 CFR § 1.97(e)**

The undersigned certifies:

[ ] 1 that each item of information contained in the information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement; or

[X] 2 that no item of information contained in the information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing the statement after making reasonable inquiry, no item of information contained in the information disclosure statement was known to any individual designated in §1.56(c) more than three months prior to the filing of the information disclosure statement.

**Provision of Copies of References**

[ ] A copy of each of the references listed on the attached Form PTO-1449 is enclosed herewith and forms a part hereof.

[ ] A translation of Reference \_\_\_\_\_ is enclosed herewith and forms a part hereof.

[ ] A copy of the European Search Report from a corresponding or related EPO application is enclosed herewith.

[ ] A copy of the International Search Report from a corresponding or related PCT application is enclosed herewith.

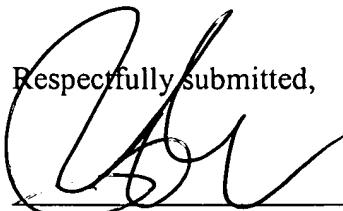
[ ] Copies of Foreign Patent Documents and Other Documents provided.

**Identification of Prior Application(s) In Which Listed Information Was Already Cited And For Which No Copies Are Submitted Or Need Be Submitted**

[ ] This application relies, under 35 U.S.C. § 120, on the earlier filing date of prior U.S. Application No(s). , filed . The following references were submitted to, and/or cited by, the Office in the prior application(s) and therefore are not required to be provided in this application:

The Commissioner is hereby authorized to charge any fees associated with this communication or credit any overpayment to Deposit Account No. 04-1679.

Date: 12.15.04

Respectfully submitted,  
  
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Registration No. 32,021

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Substitute for form 1449A/PTO <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(use as many sheets as necessary)</i>		ATTY. DOCKET NO. D0932-00447	APPLICATION NO.
		FIRST NAMED APPLICANT	EXAMINER
		FILING DATE	GROUP
Sheet 1 of 1			

**U.S. PATENT DOCUMENTS**

EXAMINER INITIALS	Cite No.	DOCUMENT NUMBER	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
A		6,399,694	McGrath et al.	Jun 4, 2002	
B		4,764,420	Gluck et al.	Aug 16, 1988	
C		3,998,944	Long	Dec 21, 1976	
D					
E					
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G					
H					

**FOREIGN PATENT DOCUMENTS**

EXAMINER INITIALS	Cite No.	Office	DOCUMENT NUMBER	COUNTRY	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T

**OTHER DOCUMENTS**

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.
EXAMINER SIGNATURE		DATE CONSIDERED

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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(use as many sheets as necessary)</i>		FIRST NAMED APPLICANT Toas, Murray	EXAMINER Matzek, Matthew D.
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## FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	Cite No.	Office	DOCUMENT NUMBER	COUNTRY	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T
A			WO 99 426	PCT	1999-08-26	Abstract	
B			02211519	Great Britain	July 5, 1989	Abstract	
C			048317	Hungary	1989-95-29	Abstract	
D			01031738A	China	1989-03-15	Abstract	
E			1271795	China	2000-11-01	Abstract	
F			1270254	China	2000-10-18	Abstract	
G			2002 37789	Japan	2002-02-06	Abstract	
H			2001288697	Japan	2001-10-19	Abstract	
I			20011271293	Japan	2001-10-02	Abstract	
J			2000248495	Japan	2000-09-12	Abstract	
K			2000248488	Japan	2000-09-12	Abstract	
L			2000192396	Japan	2000-07-11	Abstract	
M			2000119995	Japan	2000-04-25	Abstract	
N			2000110099	Japan	2000-04-18	Abstract	
O			2000 93345	Japan	2000-04-04	Abstract	
P			2000086413	Japan	2000-03-28	Abstract	
Q			2000080596	Japan	2000-03-21	Abstract	
R			1133596	Japan	1999-12-07	Abstract	

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S			11256494	Japan	1999-09-21	Abstract	
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U			11181697	Japan	1999-07-06	Abstract	
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AA			47900086	Japan	Mar 8 1986	Abstract	

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FIRST NAMED APPLICANT

EXAMINER

Toas

Matzek, Matthew D.

FILING DATE

GROUP

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PATENT & TRADEMARK OFFICE**PATENT LITERATURE DOCUMENTS**

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.
	A	DAISAN, Sanitary & Paper Products: "Kokin Mask", New Cosmetic & Household Products in Japan, 1998-07-15, ISSN 0362-4331, Abstract, Japan
	B	Research & Development: Totsuya Enters Antibacterial Packaging Business, New Cosmetic & Household Products in Japan, 1998-04-15, ISSN 0362-4331, Abstract, Japan
	C	Antibacterial Washi Paper for Japanese-Style Dinner Tray, Innovative New Packaging in Japan, 1997-07-15, Abstract, Japan
	D	Antibacterial Paper Finds First Use as a Food Container, Innovative New Packaging in Japan, 1997-07-15, Abstract, Japan
	E	Atech's Antibacterial Japanese-style Catching Notice, Innovative New Packaging In Japan, 1997-06-15, Abstract, Japan
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	I	OKAZAKI, Industrial outlook on high-performance paper, Kinoshi Kenkyu Kaishi, 1999, V38, pp 93-101, Heading Info
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	K	KLEEMAN, Biocides in the production of packaging papers, Papermakers Conference Proceedings, 1999, V2, pp 805-812, Abstract
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